

**Search Notes**

Application/Control No.

10/088,522

Examiner

Young J. Kim

Applicant(s)/Patent under  
Reexamination

VINET ET AL.

Art Unit

1637

**SEARCHED**

Class	Subclass	Date	Examiner
435	6	7/22/2005	YJK
	91.1	7/22/2005	YJK
	91.2	7/22/2005	YJK
536	23.1	7/22/2005	YJK
	24.3	7/22/2005	YJK
	24.33	7/22/2005	YJK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
435	6	7/22/2005	YJK
	91.1	7/22/2005	YJK
	91.2	7/22/2005	YJK
536/23.1,24.3,24.33		7/22/2005	YJK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	7/22/2005	YJK
See enclosed for search strategy	7/22/2005	YJK